

Description:

This P-Channel MOSFET uses advanced trench technology and

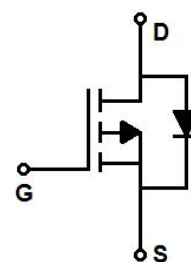
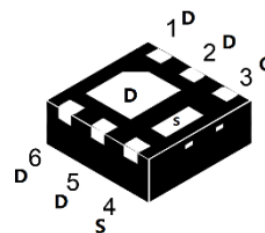
design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

- 1) $V_{DS}=-30V, I_D=-12A, R_{DS(on)} < 15m\Omega @ V_{GS}=-10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(on)}$.

Excellent package for good heat dissipation.



Package Marking and Ordering Information:

Part NO.	Marking	Package	Packing
RC015PG	C015P	DFN2*2-6	3000pcs/Reel

Absolute Maximum Ratings: ($T_A=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current- $T_A=25^\circ\text{C}$	-12	A
	Continuous Drain Current- $T_A=100^\circ\text{C}$	-6.8	
I_{DM}	Pulsed Drain Current	-60	
P_D	Power Dissipation- $T_A=25^\circ\text{C}$	3	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics:

Symbol	Parameter	Max	Units
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	41.7	$^\circ\text{C}/\text{W}$

Electrical Characteristics: ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250 μ A	-30	---	---	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} =0V, V _{DS} =-30V	---	---	-1	μ A
I _{GSS}	Gate-Source Leakage Current	V _{GS} =± 20V, V _{DS} =0A	---	---	± 100	nA
On Characteristics						
V _{GS(th)}	Gate-Source Threshold Voltage	V _{GS} =V _{DS} , I _D =250 μ A	-1.1	-1.5	-1.9	V
R _{DS(ON)}	Drain-Source On Resistance	V _{GS} =-10V, I _D =-8A	---	12	15	m Ω
		V _{GS} =-4.5V, I _D =-6A	---	15	23	
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} =-15V, V _{GS} =0V, f=1MHz	---	1229	---	pF
C _{oss}	Output Capacitance		---	159	---	
C _{rss}	Reverse Transfer Capacitance		---	144	---	
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DD} =-15V R _{GEN} =3 Ω , V _{GS} =-10V	---	17	---	ns
t _r	Rise Time		---	21	---	ns
t _{d(off)}	Turn-Off Delay Time		---	54	---	ns
t _f	Fall Time		---	41	---	ns
Q _g	Total Gate Charge	V _{GS} =-410V, V _{DS} =-15V, I _D =-10A	---	26.3	---	nC
Q _{gs}	Gate-Source Charge		---	5	---	nC
Q _{gd}	Gate-Drain “Miller” Charge		---	4.2	---	nC
Drain-Source Diode Characteristics						
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =-1A	---	-0.75	-1	V
I _S	Diode Forward Current	V _D =V _G =0V	---	---	-12	A
I _{sm}	Pulsed Source Current	V _D =V _G =0V	---	---	-60	A
T _{rr}	Reverse Recovery Time	I _S =-10A , dI/dt=100A/μs , T _J =25 °C	---	32	---	ns
Q _{rr}	Reverse Recovery Charge		---	28	---	nC

Typical Characteristics: ($T_A=25^{\circ}\text{C}$ unless otherwise noted)

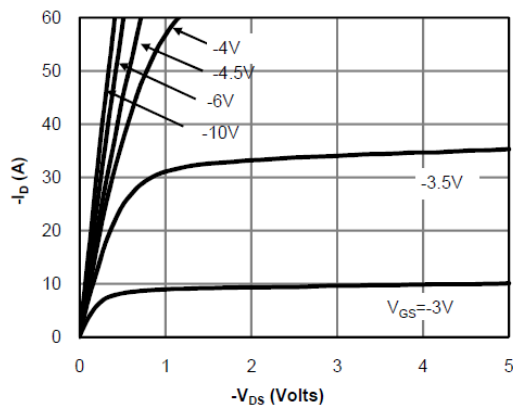


Figure 1. On-Regin Characteristics

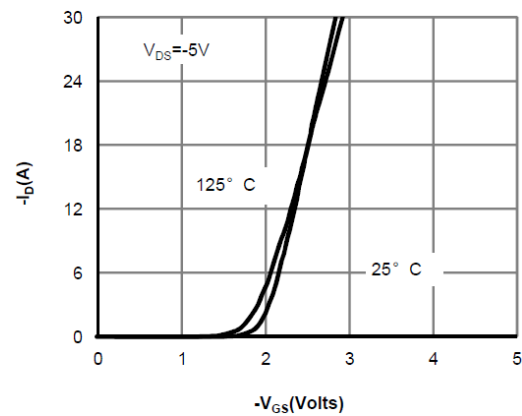


Figure 2. Transfer Characteristics

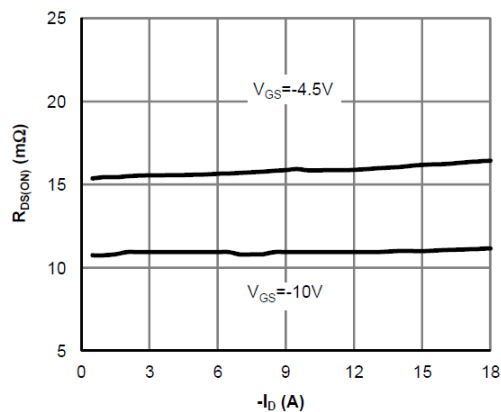


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

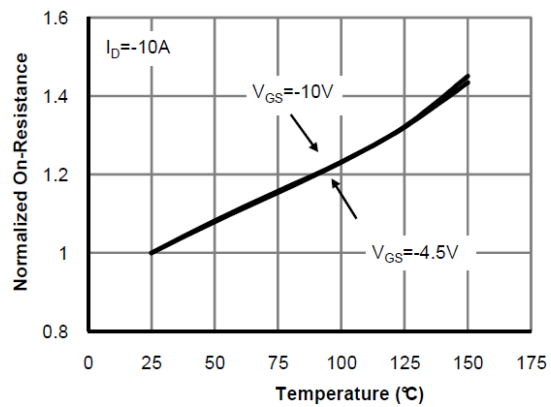


Figure 4. On-Resistance vs. Junction Temperature

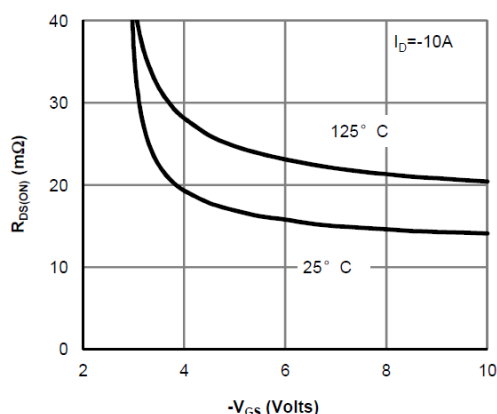


Figure 5. On-Resistance vs. Gate-Source Voltage

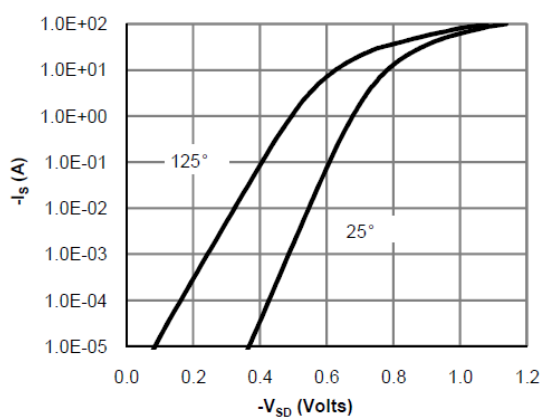


Figure 6. Body-Diode Characteristics

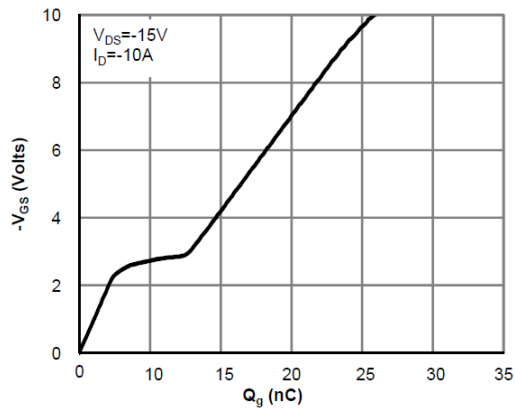


Figure 7. Gate-Charge Characteristics

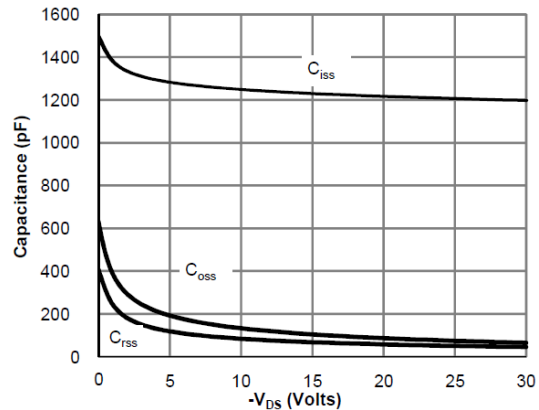


Figure 8. Capacitance Characteristics

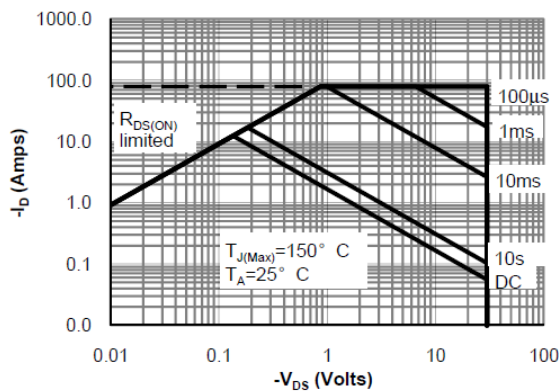


Figure 9. Maximum Forward Biased Safe Operating Area

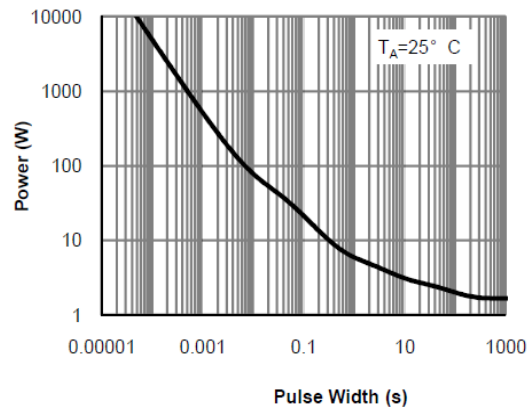


Figure 10. Single Pulse Power Rating Junction-to-Ambient

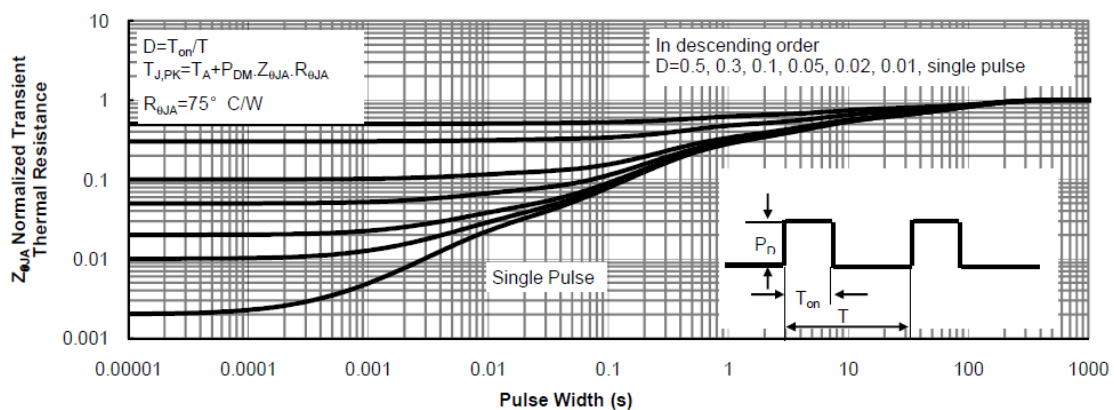
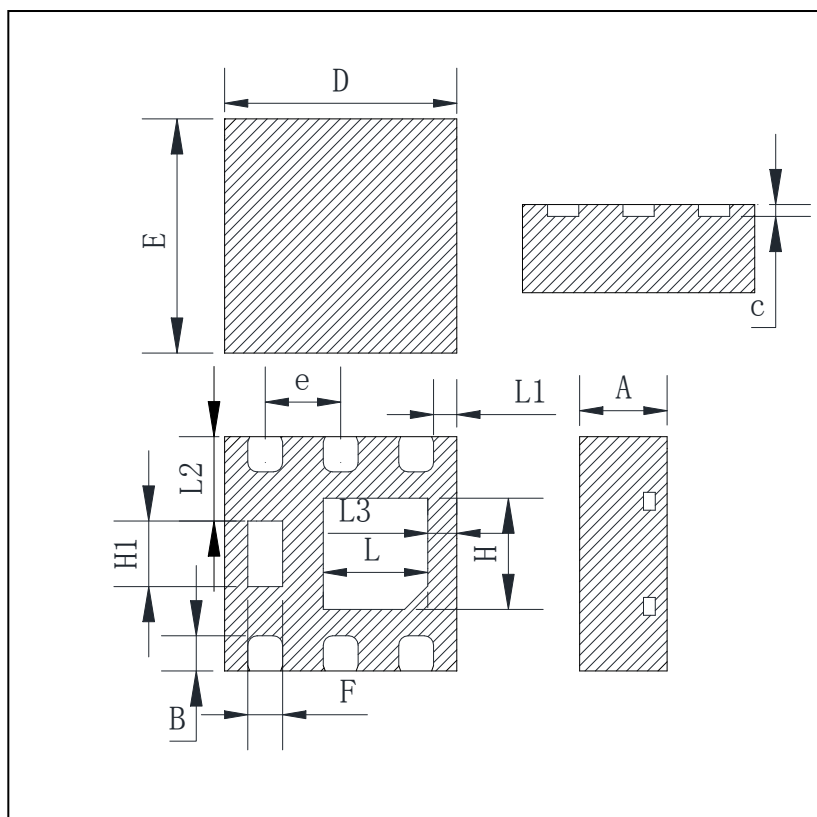


Figure 11. Normalized Maximum Transient Thermal Impedance

DFN2X2-6 Package Outline Data


Symbol	Min	Typ	Max
A	0.70	0.75	0.80
B	0.25	0.30	0.35
C	0.153	0.203	0.253
D	1.90	2.00	2.10
E	1.90	2.00	2.10
e	0.60	0.65	0.70
F	0.25	0.30	0.35
H	0.90	1.00	1.10
H1	0.50	0.60	0.65
L	0.80	0.90	1.00
L1	0.15	0.20	0.25
L2	0.60	0.70	0.80
L3	0.25	0.30	0.35

UNIT: mm

Marking Information:

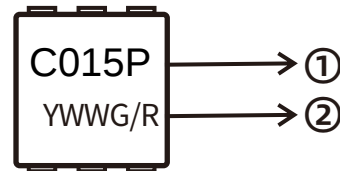
①: Part NO.

②: Date Code (YWWG / R)

Y: Year Code , last digit of the year

WW : Week Code (01-53)

G/R: G(Green) /R(Lead Free)



Previous Version

Version	Date	Subjects (major changes since last revision)
1.0	2024-07-08	Release of final version

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